

**Search Notes**

Application/Control No.

10/553,452

Examiner

Quynh H. Nguyen

Applicant(s)/Patent under  
Reexamination

LE CREFF ET AL.

Art Unit

2614

**SEARCHED**

Class	Subclass	Date	Examiner
379	211.02 199 200	4/12/07	QN
370	522	4/12/07	QN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched: East, USPGPub, USPAT, JPO,EPO	4/12/07	QN
Inventor searched in PALM database	4/12/07	QN